

DataGeneral

**TECHNICAL
STATEMENT**

TEXT LISTING

068-000271-05

PROGRAM

ECLIPSE MULTI-PROGRAMMING
RELIABILITY (LONG)

TEXT TAPE

097-000271-05

ABSTRACT

THE ECLIPSE MULTI-PROGRAMMING RELIABILITY TEST (LONG) CONSISTS OF A SERIES OF TESTS AND A SUPERVISOR PROGRAM (THE DIAGNOSTIC LINKER). THIS VERSION INCLUDES THOSE TESTS THAT APPLY TO THE CPU, MEMORY, FLOATING POINT AND THE MMPU PLUS PRIMARY DEVICE CODE TESTS FOR THE NOVA DISK, MOVING HEAD DISK, MAGNETIC TAPE, CASSETTE TAPE AND LINE PRINTER.

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; NAME: EMORTL.IX PART NUMBER: 097-000271
; DESCRIPTION: ECLIPSE MULTI-PROGRAMMING RELIABILITY
; LONG VERSION
; REVISION HISTORY:
; REV. DATE
; 04 09/01/77
; 05 10/06/78
; COPYRIGHT © DATA GENERAL CORPORATION, 1975, 1976, 1977, 1978
; ALL RIGHTS RESERVED.
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PATCH=0
; FILE FOR EMORTL.VI CPU AND PRIMARY DEVICES
000000 SHORT=0
000001 ERCCF=1
000000 CBHDS=0
000000 ADHDS=0
000000 EISTS=0
000000 ARITH=0
000000 EATS=0
000000 FPUIS=0
000000 LEFIS=0
000000 COMER=0
000000 SCMTS=0
000000 DCUTS=0
000000 ACSTS=0
000000 PGDSK=0
000000 MVDISK=0
000000 PZDSK=0
000000 MTIES=0
000000 CAFES=0
000000 LPTIS=0
000001 P.DSK=1
000001 W.DSK=1
000001 SZOSK=1
000001 M.XOSK=1
000001 CXTES=1
000001 MXTES=1
000001 IOTIS=1
000000 PITIS=0
000000 LUSR .MAPD=0
000001 ZLOAD=1

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10003 .MAIN

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01 IF THE MOVING HEAD DISKS ARE TO BE
02 EXERCISED THEY MUST HAVE A PACK INSTALLED
03 AND BE IN THE READY STATE
04 IF MAGNETIC TAPES ARE TO BE EXERCISED
05 THEY MUST BE ON LINE WRITE ENABLED
06 IF CASSETTES ARE TO BE EXERCISED
07 THEY MUST BE ON LINE WRITE ENABLED
08 IF THE LINE PRINTER IS TO BE EXERCISED
09 IT MUST BE ON LINE AND IN THE READY STATE
10 IF THE DCU 50 TEST IS TO BE RUN AT A DEVICE CODE
11 OTHER THAN 64 ONE LOCATION HAS TO BE CHANGED SUCH
12 IT CONTAINS THE DCU 50 DEVICE CODE.SEE DCU=50 TEST
13 LOCATION DCUUV:
EQU 000000 PATCH=DCUUV
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KEY ENTERED SWITCH OPTIONS(SWREG)

THE UTILIZATION OF KEYPENTERED OPTIONS HAS BEEN IMPLEMENTED SUCH THAT THE CONSOLE "MONITOR" FUNCTION CAN BE FULLY UTILIZED WITHOUT INTERFERING WITH PROGRAM FLOW.

KEY 0 LOCKS THE SWMPACKAGE INTO INPUT MODE ALLOWING SETUP OF THE CONTENTS OF "SWREG". TYPE A CARRAGE RETURN TO EXIT.

TYPING KEY'S 1 - 9,A - F SETS/RESETS SWREG BITS 1 - 9,10 - 15 RESPECTIVELY. EACH KEY ENTRY COMPLEMENTS THE PREVIOUS STATE OF THE SWREG BIT.

KEY SWREG BIT FUNCTION

1 = 1 DELETE TTY TYPEOUTS

2 = 1 DELETE MEM ALLOCATION TABLE FROM TYPEOUTS

3 = 1 INCREASES THE CHANCE OF SELECTION OF THE TTY AND LPT TEST.

4 = 4 TYPING A 4 WILL CAUSE THE ELAPSED RUN TIME AND ACCUMULATED ERRORS TO BE TYPED ON THE TTY. (NOTE: A RTC MUST EXIST)

5 = 1 DIRECT ERROR AND RUNTIME TYPEOUTS ALSO TO THE LINE PRINTER.

6 = 1 THE ERROR ROUTINE WILL PAUSE AFTER EACH PHASE OF AN ERROR TYPEOUT. TYPE A CR KEY ON DEVICE TTY TO PROCEED.

7 = 7 TYPING A 7 WILL CAUSE INDIVIDUAL RUN STATISTICS OF EACH TEST TO BE LISTED.

F = 1 DOESN'T RELEASE OR ALLOW REASSIGNMENT OF SCRATCH AREAS AFTER ERROR.

NOTE (C) = CONTROL KEY

KEY M PRINTS THE CURRENT CONTENTS OF SWREG.

KEY (C)D RESTARTS THE PROGRAM AT LOC 202 AFTER RESETTING SWREG TO ALL 0'S

KEY (C)R RESTARTS THE PROGRAM AT LOC 202 WITHOUT DISTURBING SWREG.

EXAMPLE:

TO DELETE ERROR TYPEOUTS AND LOOP ON FAILING SCRATCH AREAS TYPE 01,F, AND CR.


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;5.1.7 FLOATING POINT AC'S
;
; ALL CPU TESTS WHICH MAKE USE OF THE FLOATING
; POINT WILL IN THEIR ERROR OUTPUT INCLUDE THE CURRENT
; STATE OF THE FPSR AND FPAC0 THRU FPAC3 IN THE FOLLOWING
; FORMAT:
;
; FPSR = SSSSSS SSSSSS
; FPAC0-3
; 0 15 16 31 32 47 48 63
; XXXXX XXXXX XXXXX XXXXX
; YYYYY YYYYY YYYYY YYYYY
; ZZZZZ ZZZZZ ZZZZZ ZZZZZ
; QQQQQ QQQQQ QQQQQ QQQQQ
;
; WHERE XXXXX = FPAC0
; YYYYY = FPAC1
; ZZZZZ = FPAC2
; QQQQQ = FPAC3
;
;5.1.8 RELOCATED CODE ERROR
;
; UPON DETECTION OF AN ERROR BY A RELOCATED TEST
; THE RELOCATED CODE IS COMPARED TO THE ORIGINAL
; COPY. IF A DIFFERENCE IS FOUND THE FOLLOWING
; INFORMATION IS TYPED:
;
; RELOCATED CODE ERROR
; EXPECTED ACTUAL ADDR=E ADDR=A
; XXXX YYYYY QQQQQ ZZZZ
;
; WHERE,
; XXXX IS THE ORIGINAL WORD
; YYYYY IS THE RELOCATED WORD
; QQQQQ IS THE ADDRESS OF ORIGINAL
; ZZZZ IS THE ADDRESS OF RELOCATED WORD
;
; WHEN THIS OCCURS THE ERROR WAS
; PROBABLY CAUSED BY THE MODIFICATION OF THE
; RELOCATED CODE.

;5.1.7
;
; ERROR ANALYSIS
; DUE TO THE INTERACTIVE NATURE OF
; THE TESTS INVOLVED, A SERIES OF
; ERROR TYPEOUTS WILL PROBABLY BE
; REQUIRED FOR ANALYSIS BEFORE A
; PROBLEM WILL BE ISOLATED.
; A RESTART AT 202 AND DELETION OF ALL
; BUT THE TEST THAT ORIGINALLY
; FAILED MAY HELP TO ISOLATE
; INTERACTIVE PROBLEMS AS FOLLOWS:
;
; IF THE TEST RUNS BY ITSELF THE PROBLEM
; IS INTERACTIVE-RE-ENABLE ONE OTHER TEST AT
; A TIME TO DETERMINE WHICH ONE IS THE PROBLEM.
; IF THE TEST DOES NOT RUN BY ITSELF
; RESORT TO SIMILAR BUT LOWER LEVEL TESTS
; FOR ISOLATION
;
;5.5 PERTINENT MEMORY LOC'S TYPED
;
;5.3.1 CHECKERBOARD RAN
;
; THE AC'S AT ERROR WILL INDICATE:
;
; GOOD DATA - BAD DATA-LOGICAL ADDRESS
;
; IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
;
; CB.TK TEST COUNTER
; 0 GENERATE CHECKERBOARD
; 1 DISTURB PASS
; 2 CHECK PATTERN
; 3 CHECKSUM THE # OF -1'S IN PATTERN
;
; CB.LC STARTING LOGICAL ADDRESS OF "BEGIN"
;
; CB.SE AC3 AT ERROR CALL

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:5.5.2 EIS/MRI TEST
:
: THE AC'S WILL BE TYPED AS THEY WERE AT THE
: TIME OF ERROR DETECTION
:
: IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
: EI.TK SEE DISCUSSION OF TEST FOR THE
: SEQUENCE BEING EXECUTED
: EI.LO LOW LIMIT OF SCRATCH AREA AFTER IT WAS
: REMAPPED FOR EXECUTION
: EI.LA LOGICAL START OF TEST AFTER REMAP
: (SEE DISCUSSION OF ST.LA,ETC AT PARA.5.1.6)
:
:5.3.3 ARITHMETIC TEST
:
: THE AC'S WILL BE TYPED AS THEY WERE AT THE
: TIME OF ERROR DETECTION
:
: IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
: AT.LC STARTING ADDRESS OF ARITH IN SCRATCH
: AT.LO LOW LIMIT OF SCRATCH AREA AFTER IT IS
: REMAPPED FOR EXECUTION
: AT.LA AT.LC IN RELATION TO AT.LO
: (LOGICAL START OF ARITH AFTER REMAPPING)
: THE LAST THREE RANDOM NUMBERS GENERATED
: (SEE DISCUSSION OF ST.LA,ETC AT PARA.5.1.6)
:
:5.3.4 ADDRESS TEST
:
: THE AC'S 0 1 AND 2 WILL
: BE TYPED AS THEY
: WERE AT THE TIME OF ERROR
: DETECTION
: AC0 WILL CONTAIN THE ADDRESS THAT COMPARE WILL
: STOP AT (AC0<AC2COMPARE IS TOP TO BOTTOM)
: AC1 WILL CONTAIN THE DATA FOUND TO BE INCORRECT
: OF THE ADDRESS THAT FAILED
: AC3 WILL CONTAIN THE CURRENT RANDOM OFFSET
: IN ADDITION THE FOLLOWING LOC.'S WILL BE TYPED:
: A.TSK TEST COUNTER
: 0. ADRS. TO ADRS LOADED LOW TO HIGH
: 2 COM. ADRS TO ADRS LOW TO HIGH
: 4 ADRS. TO ADRS LOADED HIGH TO LOW
: 6 COM. ADRS TO ADRS LOADED HIGH TO LOW
: 10 ADRS TO ADRS LOADED LOW TO HIGH
: 15, AND 11 COMPARE EACH ADRS. TO EQUAL ITSELF
: 3 AND 7 COMPARE EACH ADRS. TO EQUAL ITS COM.
: AD.ST STARTING ADDRESS OF TEST IN CORE
: AD.S3 ADRS. (AC3) OF ERROR CALL
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10012 .MAIN
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:5.3.5 EXTENDED ADDRESSING TEST
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: THE AC'S WILL BE TYPED AS THEY WERE AT THE
: TIME OF ERROR DETECTION
:
: IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
: LA.LC START ADRS. OF TEST
: FOR RELOCATION
: LA.LO LOW LIMIT OF SCRATCH AREA AFTER IT WAS
: REMAPPED FOR EXECUTION
: LA.LA LOGICAL START OF TEST AFTER REMAP
: (SEE DISCUSSION OF ST.LA,ETC AT PARA.5.1.6)
:
:5.3.6 FLT PT TEST
:
: THE AC'S WILL BE TYPED AS THEY WERE AT THE
: TIME OF ERROR DETECTION
:
: IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
: FP.LC START ADRS. OF FLT. PT. TEST
: FOR RELOCATION
: FP.LO LOW LIMIT OF SCRATCH AREA AFTER IT WAS
: REMAPPED FOR EXECUTION
: FP.LA LOGICAL START OF TEST AFTER REMAP
: (SEE DISCUSSION OF ST.LA,ETC AT PARA.5.1.6)
:
:5.3.7 LEF/ERROR TEST
:
: THE AC'S WILL BE TYPED AS THEY WERE AT THE
: TIME OF ERROR DETECTION
:
: IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
: LF.LC START ADRS. OF TEST
: FOR RELOCATION
: LF.LO LOW LIMIT OF SCRATCH AREA AFTER IT WAS
: REMAPPED FOR EXECUTION
: LF.LA LOGICAL START OF TEST AFTER REMAP
: (SEE DISCUSSION OF ST.LA,ETC AT PARA.5.1.6)
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10013 .MAIN
01 : 5.5.8 SC MEMORY TEST
02 :
03 : THIS IS AN ISZ/DSZ TEST FOR SC-MEMORIES.
04 :
05 : THE AC'S AT ERROR WILL INDICATE:
06 : ACTUAL-EXPECTED-LOGICAL ADDRESS
07 :
08 : IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
09 : MM,TK ERROR NUMBER:
10 : 0 PATTERN STORING ERROR(SHO BE -1)
11 : 1 LOCATION NOT -1 BEFORE DOING ISZ
12 : 2 ISZ DIDN'T SKIP
13 : 3 LOCATION NOT EQUAL TO 0 AFTER ISZ
14 : 4 DSZ SKIP ERROR
15 : 5 DSZ TEST-LOCATION NOT -1 AFTER DSZ
16 : 6 SAME AS 1, EXCEPT TESTING IN REV DIRECTION
17 : 7 SAME AS 2, EXCEPT " " " " "
18 : 8 SAME AS 3, EXCEPT " " " " "
19 : MM,SE INSTRUCTION ADDRESS FOLLOWING ERROR CALL
20 : LOCATION ADDRESS OF FAILING LOCATION(LOGICAL)
21 :
22 : 5.5.9 DCU TEST
23 :
24 : THIS IS AN ARITHMETIC TEST PERFORMED BY THE
25 : OCU-50 USING THE DATA CHANNEL.
26 :
27 : THE AC'S AT THE TIME OF ERROR DETECTION WILL
28 : BE TYPED.
29 : IN ADDITION THE FOLLOWING DATA IS TYPED:
30 : RANDOM DATA ACU,AC1,AC2
31 : UCLPK LOGICAL START OF LOOP
32 : DCLEL LOGICAL ERROR ADDR
33 : DC.LA LOGICAL START OF TEST
34 : DC.LP LISTING START OF TEST
35 : ERROR LISTING ADDR OF ERROR

10014 .MAIN
01 : 5.5.10 MCS TEST
02 :
03 : THE AC'S WILL BE TYPED AS THEY WERE AT THE TIME
04 : OF ERROR DETECTION.
05 :
06 :
07 : IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
08 :
09 : MS.LC STARTING ADDRESS OF MCS TEST IN SCRATCH
10 : AS.LU LOW LIMIT OF SCRATCH AREA AFTER IT IS
11 : REMAPPED FOR EXECUTION.
12 : AS.LA AS.LC IN RELATION TO MS.LO
13 : (LOGICAL START OF MCS TEST AFTER REMAPPING)
14 : THE LAST THREE NUMBERS GENERATED
15 : (SEE DISCUSSION OF ST.LA,ETC. AT PARAGRAPH 5.1.6)
16 :
17 : 5.5.11 COMMERCIAL INSTRUCTION TEST
18 :
19 : THE AC'S WILL BE TYPED AS THEY WERE AT THE
20 : TIME OF ERROR DETECTION
21 :
22 : IN ADDITION THE FOLLOWING LOCATIONS ARE TYPED:
23 : CM.LC START ADDR OF TEST(RELOCATED)
24 : CM.LU LOW LIMIT OF SCRATCH AREA AFTER IT
25 : WAS REMAPPED FOR EXECUTION
26 : CM.LA LOGICAL START OF TEST AFTER REMAP
27 : (SEE DISCUSSION OF ST.LA,ETC. AT PARA. 5.1.6)

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10031 .MAIN
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;5.4.4 ARITHMETIC TEST
;
;THE MULTIPROGRAMMING RELIABILITY ARITHMETIC TEST WAS
;DERIVED FROM THE STAND ALONE ARITHMETIC TEST. THIS TEST
;REQUIRES 2K OF SCRATCH FOR EXECUTION. THE EXECUTE PORTION
;OF THE TEST IS RANDOMLY RELOCATED WITHIN AVAILABLE
;SCRATCH. IF THE SYSTEM IS MAPPED, (HAS AN MDPV) THE
;SCRATCH AREA IS RANDOMLY REMAPPED TO SOME OTHER LOGICAL ADDRESS
;FOR EXECUTION. AT THE END OF EACH EXECUTION PASS SCRATCH
;AREA IS RANDOMLY RELEASED OR HELD. IF HELD, THE NEXT TIME
;AGAIN BE RANDOMLY RELOCATED WITHIN SCRATCH FOR EXECUTION.
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;5.4.5 ADDRESS TEST
;
;THE MULTIPROGRAMMING ADDRESS TEST GENERATES A VARIETY OF
;4 ADDRESS AND COMPLIMENT ADDRESS PATTERNS IN AVAILABLE
;SCRATCH. THE TEST SEQ FOLLOWS:
;
;A.TSK=0
;SELECT A SCRATCH AREA TO WORK IN, MOVE THE
;EXECUTE PORTION OF THE ADDRESS TEST TO
;EITHER THE HIGH OR LOW END OF SCRATCH
;GENERATE THE ADDRESS TO ADDRESS PAT-
;TERN IN THE UPWARD (LOW SCRATCH TO HIGH
;SCRATCH) DIRECTION, THE PATTERN IS GEN-
;ERATED IN TWO STEPS. FIRST A RANDOM # OF
;WORDS (OFFSET A.AOS) IS FILLED VIA A HAM
;:(ADRS(AC2))+1(ACU) TO ADRS(AC3) THE
;NEXT OF SCRATCH IS FILLED VIA A SECOND HAM
;:(ADRS(AC2))*(OFFSET+1(AC0) TO ADRS AC3.
;
;A.TSK=1
;VERIFY THAT EACH SCRATCH LOCATION CONTAINS
;ITS OWN LOGICAL ADDRESS.
;
;A.TSK=2
;PATTERN GENERATION IS PERFORMED AS IN
;A.TSK=0 EXCEPT THAT THE 2 HAM'S FILL EACH
;SCRATCH LOCATION WITH THE 1'S COMPLIMENT OF
;ITS LOGICAL ADDRESS.
;
;A.TSK=3
;VERIFY THAT EACH LOCATION CONTAINS THE 1'S
;COMPLIMENT OF ITS LOGICAL ADDRESS.
;
;A.TSK=4
;EACH SCRATCH LOCATION IS AGAIN FILLED WITH
;ITS OWN LOGICAL ADDRESS. HOWEVER, THE PATTERN IS
;GENERATED IN THE DOWNWARD DIRECTION (HIGH SCRATCH
;TO LOW SCRATCH) TWO STEPS ARE TAKEN. A RANDOM
;# OF WORDS EQUAL TO OFFSET (A.AOS) ARE FILLED
;WITH THEIR LOGICAL ADRS. THE REST OF SCRATCH IS
;THEN FILLED VIA AN LDA AC2+OFFSET, OFFSET IS
;SUBTRACTED AND THE AN 5TH INTO THE LOWER
;LOCATION,
;
;A.TSK=5
;(SEE A.TSK=1)
;
;A.TSK=6
;GENERATION IS AS A.TSK=4 EXCEPT EACH LOCATION
;IS FILLED WITH THE 1'S COMPLIMENT OF ITS
;LOGICAL ADDRESS
;
;A.TSK=7
;(SEE A.TSK=3)
;
;A.TSK=10
;THE PATTERN GENERATION OF A.TSK=0 IS REVER-
;
;A.TSK=11
;(SEE A.TSK=1)

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03      ;6.4.6 EXTENDED ADDRESSING TEST
04      ;THE EXTENDED ADDRESSING TEST
05      ;VERIFIES THE CORRECT OPERATION OF THE DOUBLE LENGTH
06      ;INSTRUCTIONS,THE IMMEDIATE MODE DOUBLE LENGTH,
07      ;DISPA,CLM,MSP,HLV AND ELEF.
08      ;SCRATCH AREA IS TREATED AS INTHE EIS/MMI TEST
09      ;WITH TEST EXECUTION SIMILAR TO THE ARITH,FLT PT.
10      ;AND LEF/ERROR TESTS
11      ;6.4.7 FLOATING POINT TEST
12      ;
13      ;THE MULTIPROGRAMMING FLOATING POINT TEST IS SIMILAR IN OP-
14      ;ERATION TO THE ARITHMETIC TEST. THE FPU TEST DATA BUFFER IS
15      ;LOCATED RANDOMLY WITHIN 32 WORDS IN THE CENTER OF THE EX-
16      ;ECUTE PORTION OF THE FLT PT TEST. THE FLT. PT. NUMBERS PRO-
17      ;CESSED BY THIS TEST ARE FIXED (NOT RANDOM) AND CAN BE FOUND
18      ;SPECIFIED ON THE LISTING FOR EACH TEST.
19      ;
20      ;6.4.8 LEF/ERROR TEST
21      ;
22      ;THE LEF MODE - ERROR TEST IN MULTIPROGRAMMING RELIABILITY IS
23      ;ONLY RUN IF AN MPMU EXISTS. THE LEF PORTION OF THIS TEST VERIFIES
24      ;THAT THE LEF ENABLE ON THE MPMU FUNCTIONS IN ALL ADDRESSING
25      ;MODES. THE ERROR PORTION OF THE TEST VERIFIES THAT THE WRITE, I/O
26      ;DEFER AND VALIDITY PROTECT FEATURES OF THE MPMU FUNCTION
27      ;CORRECTLY. SCRATCH AND EXECUTION ARE TREATED AS IN ARITH-
28      ;METIC TEST.
29      ;
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;6.4.9 COMMERCIAL INSTRUCTION TEST
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;UPON ENTERING FOR INITIALIZATION THIS TEST DOES A TRIAL
;INSTRUCTION TO DETERMINE IF THE COMMERCIAL OPTION AND
;THE FLOATING POINT OPTION ARE INSTALLED TOGETHER.
;UPON ENTERING FOR EXECUTION THE TEST TRIES TO ACQUIRE
;4K OF SCRATCH. IF OBTAINED THE TEST MODULE IS
;MOVED UP INTO SCRATCH LEAVING THE AREA ABOVE AND
;BELOW THE TEST AS DATA SCRATCH BUFFERS.
;THE SIX INSTRUCTIONS TESTED ARE: ELDB,ESTB,CMV,CMP
;CTK, AND CMT.
;THE EXTENDED LOAD BYTE/STORE BYTE INSTRUCTIONS ARE
;TESTED TOGETHER. A RANDOM BYTE ADDRESS IS GENERATED IN
;EITHER THE HIGH OR THE LOW SCRATCH BUFFER. A RANDOM
;NUMBER (16 BITS) IS THEN STORED INTO MEMORY LOCATION
;CONTAINING THAT BYTE. BITS 8-15 OF THIS RANDOM NUMBER
;IS AGAIN STORED INTO THAT BYTE ADDRESS BY THE ESTB INSTR.
;THESE TWO ADJACENT BYTES OF THE SAME WORD ARE THEN LOADED
;ONE AT A TIME BY THE ELDB INSTRUCTION. BACK INTO THE ACCUM.
;THE RANDOM NUMBER IS HENCE RECONSTRUCTED AND COMPARED WITH
;THE ORIGINAL FOR ERROR. THIS EXERCISE CHECKS THAT THE ELDB,
;ESTB INSTRUCTIONS DO NOT DISTURB THE ADJACENT BYTES.
;ALL FOUR ADDRESSING MODES ARE TESTED SEPERATELY.
; THE CMV, CMP, CTR, AND CMT INSTRUCTIONS ALL DEAL
;WITH STRINGS OF BYTES FROM A SOURCE TO A DESTINATION
;FIELD. THE SIZES OF THE LOW AND HIGH BUFFER ARE COMPARED
;AND THE SMALLER BUFFER IS SELECTED AS THE SOURCE COMPARED
;BUFFER WHILE THE LARGER IS THE DESTINATION. THE SOURCE
;BUFFER IS FILLED WITH RANDOM DATA AT THE START OF THE
;TEST IN ORDER TO MINIMIZE THE USE OF THE RANDOM DATA
;GENERATOR. THE CMV AND CMP INSTRUCTIONS ARE EXERCISED TOGETHER.
;THE CTR AND CMT INSTR. ARE EXERCISED SEPERATELY
;AND THEIR TRANSLATION TABLE IS LOCATED RANDOMLY IN THE SOURCE
;BUFFER. SINCE THE CTR INSTRUCTION REQUIRES A TRANSLATION TAB.
;OF 128 WORDS, A SCHEME IS SETUP WHICH DIVIDES THE
;LARGER BUFFER INTO TWO HALVES. IN THIS CASE, THE LOWER HALF IS
;SIZE IS LESS THAN 256 WORDS. IN THIS CASE, THE LOWER HALF IS
;CHOSEN AS THE SOURCE AND THE UPPER HALF AS THE DESTINATION
;BUFFER.
; THE LDI,STI,LDIX,LSN AND FINI INSTRUCTIONS HANDLE THE
;CONVERSION OF INTEGERS AND FLOATING POINT NUMBERS.
;A RANDOM NUMBER IS FLOATED FROM MEMORY INTO FPACO,
;THE EXPONENT OF WHICH IS THEN RANDOMIZED. FPACO IS
;INTEGRIZED (BY FINI) AND STORED (BY STI) AS AN
;INTEGER 16 BYTES LONG. THIS INTEGER IS THEN LOADED BY
;LDI INTO FPAC1, AND COMPARED WITH FPACO FOR ERROR.
;THE SAME INTEGER IS ALSO TESTED BY THE LSN INSTRUCTION
;AND THE RETURNED CODE IN AC1 IS EXAMINED FOR ERROR.
;A SIMILAR APPROACH IS USED IN TESTING THE LDIX,STIX
;INSTRUCTIONS. ALL EIGHT FORMATS OF INTEGERS(TYPES 0-7)
;ARE TESTED SEPERATELY.
;THE EDIT INSTRUCTION IS USED TO CONVERT INTERGERS
;FROM ONE FORMAT TO THE OTHER. THREE TESTS ARE
;WRITTEN IN WHICH ALL EDIT OP CODES ARE EXERCISED.

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;6.4.15 (CONTINUED)
;
; THE TEST THEN INITIATES A SEEK TO THE CYLINDER SELECTED
; AND AT SUCCESSFUL COMPLETION OF THE SEEK EITHER READS OR
; WRITES THE # OF SECTORS AVAILABLE.
; STATUS ERROR OF DATA LATE WILL CAUSE THE TEST TO RETRY
; THE OPERATION UP TO FOUR TIMES.
; AT SUCCESSFUL COMPLETION OF EITHER THE READ OR WRITE, THE
; DATA BUFFER IS CHECKED TO VERIFY THAT IT CONTAINS THE
; CORRECT DATA. AS DATA COMPARES CORRECTLY, THE CORRECT
; WORDS ARE FILLED WITH THE NEGATIVE COUNT=TO THE NUMBER
; OF WORDS LEFT IN THE BUFFER.
;
;6.4.16 6060/61 DISK TEST
;
; THE 6060/61 DISK TEST IS SIMILAR TO THE
; MOVING HEAD DISK TEST IN OPERATION.
;
;6.4.17 MAGNETIC TAPE OR CASSETTE TEST
;
; THE MULTIPROGRAMMING MAGNETIC TAPE AND CASSETTE TESTS ARE
; IDENTICAL IN OPERATION. THREE TO SIXTY THREE RECORDS
; OF RANDOM DATA ARE WRITTEN, THE DATA BUFFER IS CHECKED,
; THE MAG TAPE OR CASSETTE IS BACKSPACED TO THE BEGIN-
; NING OF THE JUST WRITTEN RECORDS. THEN, AS MANY RECORDS
; AS THE SCRATCH AREA WILL CONTAIN ARE READ BACK, THE
; DATA IS VERIFIED AND THE SEQUENCE (READ/VERIFY) IS RE-
; PEATED UNTIL ALL RECORDS IN THE SEQUENCE HAVE BEEN READ.
;
; FOR TAPE WRITE STATUS ERRORS, THE TAPE IS BACKSPACED/RE-
; WRITTEN UNTIL THE ERROR NO LONGER OCCURS. FOR TAPE READ
; STATUS ERRORS THE TEST BACKSPACES AND REREADS A TOTAL OF
; 13 TRYS. STATUS ERRORS DURING BACKSPACE ARE CONSIDERED NON-
; RECOVERABLE. FOR ALL ERRORS TYPED, THE TAPE IS REMOVED
; AND THE TEST RESTARTED AT LOAD POINT.
;
; WHEN THE TAPE REACHES EOT DURING THE WRITE OPERATION, TAPE
; IS REMOVED AND THE TEST RESTARTS AT LOAD POINT.
;
; THE RANDOM DATA IS A SEQUENCE OF 4 WORDS REPEATED EVERY 4TH
; WORD. ALL RECORDS ARE 256 WORDS IN LENGTH. AS DATA IS
; VERIFIED IN THE BUFFER IT IS REPLACED WITH A WORD EQUAL
; TO THE NEGATIVE COUNT OF THE NUMBER OF WORDS LEFT
; TO BE COMPARED.
;
; THESE TAPE TESTS UTILIZE 1 TO 6K OF SCRATCH AND THE
; DATA BUFFER START IS RANDOMLY SELECTED TO BE IN THE FIRST 256
; WORDS.
;
; ANY COMBINATION OF 1 TO 8 DRIVES MAY BE TESTED SIMPLY BY
; HAVING THEM ON LINE WRITE ENABLED.

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10042 *MAIN
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;6.4.18 LINE PRINTER TEST
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; THE NUM-DCH LINE PRINTER TEST RANDOMLY PRINTS 10 TO 60 LINES
; PER PAGE WITH RANDOM STALLS EVERY 1 TO 9 LINES.
; EACH LINE OF PRINT CONSISTS OF THE CHARACTERS SPACE
;(40) TO Z (142). THE TEST FILLS THE PRINT BUFFER UNTIL THE
; FIRST PRINT CYCLE STARTS. CONTINUATION OF PRINTING UNTIL
; RANDOM STALL IS THEN RUN OFF INTERRUPTS FROM THE PRINTER.
; THE DCH-LINE PRINTER TEST ASSIGNS 1 TO 2K OF
; SCRATCH AND ASSIGNS IT TO THE DCH A MAP. IT THEN RANDOMLY
; CHOSSES A STARTING ADDRESS 0 TO 63 WORDS INTO THE SCRATCH AREA
; NEXT THE TEST CHOSSES 10 TO A MAXIMUM OF 60 LINES TO PRINT.
; THE PATTERN PRINTED CONSISTS OF THE CHARACTERS SPACE(40) TO
; J(135). A TAB RUNAWAY ERROR WILL RESULT IN A PROGRAMMED HALT.
;
;6.4.19 PROGRAMMABLE INTERVAL TIMER TEST
;
; THE PROGRAMMABLE INTERVAL TIMER IS SET FOR A 1 SECOND INTERVAL.
; ASSUMING THE PIT TO BE MORE RELIABLE THAN THE REAL TIME CLOCK,
; THE PIT TEST WILL UPDATE THE RTC EVERY MINUTE AND INDICATE AN
; ERROR IF THE TWO DIFFER BY MORE THAN 5% (3 SEC/MIN). IF THE
; RTC DOES NOT EXIST, THE PIT ASSUMES THE REAL TIME CLOCK'S
; RESPONSIBILITY OF REPORTING THE TIME AT 5, 15, AND 30 MINUTES
; AND EVERY 30 MINUTES THEREAFTER. THE TIME WILL ALSO BE INDICATED
; AFTER EVERY ERROR.
;
;6.4.20 REAL TIME CLOCK
;
; THE REAL TIME CLOCK IS RUN AT 1K HERTZ. RUNTIME ALONG
; WITH ACCUMULATED ERROR COUNT ARE PRINTED AT 5 MINUTES
; 15 MINUTES, 30 MINUTES AND EVERY 30 MINUTES OF RUNTIME
; THEREAFTER. THIS TYPEOUT ALSO OCCURS AFTER EVERY ERROR
; TYPEOUT OR IF A TTY KEY 4 IS TYPED.
;
;6.4.21 TELETYPE TEST
;
; THE TELETYPE TEST PRINTS A SINGLE LINE CONSISTING OF THE
; CHARACTERS SPACE TO Z. THE TEST WILL ALSO ECHO CHARACTERS
; AS TYPED.

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10043 .MAIN

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?7.0 ODT EDITOR
?7.1 REQUESTING THE ODT EDITOR
? TO ENTER THE ODI TYPE A CONTROL U ON
? THE TTI. THIS CAN BE DONE AT ANY POINT IN THE
? PROGRAM.
?7.2 ON ENTERING THE ODI A CARRIAGE RETURN, LINE FEED
? AND AN @ IS TYPED ON THE TTI.
?7.3 CONVENTIONS AND SYMBOLS IN COMMAND LINES
? *****
? CR PRESSING THE RETURN KEY IS REPRESENTED BY CR .
? LF PRESSING THE LINE FEED KEY IS REPRESENTED BY LF .
? ? PRESSING AN ILLEGAL KEY CAUSES THE ODI TO RESPOND WITH
? A ?
? @ PRESSING THE EUP-ARROW KEY IS REPRESENTED BY @ .
? @ ODI IS READY AND AT YOUR SERVICE.
?7.4 COMMAND STRUCTURE
? *****
? AN ODI COMMAND HAS THE GENERAL FORMAT:
? [ARGUMENT] [COMMAND]
? ARGUMENT MAY BE ONE OF THE FOLLOWING:
? ADR AN OCTAL ADDRESS OR AN EXPRESSION OF THE FORM:
? X+XX...
? WHERE EACH X IS AN OCTAL INTEGER, SEPARATED
? FROM THE FOLLOWING X BY EITHER +(PLUS)
? OR -(MINUS). LEADING ZEROS NEED NOT BE TYPED.
? N AN OCTAL INTEGER.
? A COMMAND IS A SINGLE TELETYPE CHARACTER
? "/ "CR" "LF" "@"
? CHARACTERS USED TO ENTER/EXIT ODI INCLUDE:
? "0"(CTRL 0) "N" "P"
? CHARACTERS USED TO MODIFY CURRENT ARGUMENTS ARE:
? "RUBOUT" "+" "-" AND THE INTEGERS 0 TO 7
? THE CHARACTER "=" ALLOWS THE CURRENT ARGUMENT TO BE
? EXAMINED WITHOUT OPENING OR CLOSING THE CURRENT LOC.
? CHARACTERS USED TO MANIPULATE THE ECLIPSE MAP INCLUDE:
? "M" "A" "B" "U" "T" "E" "L"
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10044 .MAIN

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?7.5 COMMANDS TO OPEN A LOCATION
? *****
? THE MEMORY LOCATION TO BE OPENED IS TYPED OUT.
? OPEN THE LOCATION AND PRINT ITS CONTENTS
? / OPEN THE LOCATION CURRENTLY POINTED BY THE POINTER
? AND PRINT ITS CONTENTS.
? *ADR/ ADD ADR TO THE POINTER, OPEN THE LOCATION AND
? PRINT ITS CONTENTS.
? -ADR/ SUBTRACT ADR FROM THE POINTER, OPEN THE LOCATION AND
? PRINT ADDR CONTENTS.
? CR CLOSE THE OPEN LOCATION WITH OR WITHOUT
? MODIFICATION OF ITS CONTENTS.
? LF CLOSE THE OPEN LOCATION WITH OR WITHOUT
? MODIFICATION OF ITS CONTENTS AND OPEN THE
? SUCCEEDING LOCATION.
? / CLOSE THE OPEN LOCATION WITHOUT MODIFYING
? ITS CONTENTS AND OPEN THE CELL POINTED
? BY ITS CONTENTS
? *ADR/ CLOSE THE OPEN LOCATION WITHOUT MODIFYING
? ITS CONTENTS AND OPEN THE LOCATION POINTED
? BY ITS CONTENTS+ADR
? -ADR/ CLOSE THE OPEN LOCATION WITHOUT MODIFYING ITS
? CONTENTS AND OPEN THE LOCATION POINTED BY
? ITS CONTENTS-ADR.
? @ CLOSE THE CURRENT LOCATION AND OPEN "@"-1"
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10047 .MAIN

**00025 TOTAL ERRORS, 00014 FIRST PASS ERRORS

0048 .MAIN

ADRTS 000000	2/07	11/28	32/01	
ARITH 000000	2/09	11/14	31/01	
CATES 000000	2/22	20/01	41/19	
CARDS 000000	2/06	10/22	29/23	
COMER 000000	2/13	14/17	34/01	
CATES 000001	2/28			
DCUTS 000000	2/15	3/10	3/14	13/22 35/01
EATS 000000	2/19	12/01	33/01	
ESTS 000000	2/08	11/01	30/01	
ERCCF 000001	2/05	4/43		
ERCOR 000000	2/04	25/01	29/04	
FPUTS 000000	2/11	12/13	33/09	
IOTST 000001	2/30	21/11	43/01	
LEFTS 000000	2/12	12/26	33/18	
LPTTS 000000	2/23	20/35	42/01	
MITES 000000	2/21	19/01	41/19	
MVDSK 000000	2/19	6/29	7/25	17/01 40/01
MYDSK 000001	2/27			
MXIES 000001	2/29			
NVDSK 000000	2/18	6/27	7/23	15/01 37/01
N-DSK 000001	2/25			
PATCH 177777	3/14	6/27	6/28	6/29 6/30 7/23 7/24
PGDSK 000000	7/25	7/26		
PITTS 000000	2/17	6/28	7/24	
PZDSK 000000	2/31	21/01	42/16	16/01 38/01
P-DSK 000001	2/20	6/30	7/26	18/01 41/14
SCMTS 000000	2/24			
SHORT 000000	2/14	13/01	35/13	
SZDSK 000001	2/03			
WCSTS 000000	2/26	14/01	36/01	
ZLOAD 000001	2/16			
	2/33			